## Notice of References Cited

Application/Control No. 10/790,243	Applicant(s)/Patent Under Reexamination ICHIOKA ET AL.		
Examiner	Art Unit		
Rodney H. Bonck	3681	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-5,301,775	04-1994	Nedbal et al.	188/290
	В	US-5,388,901	02-1995	Asano, Kazunori	312/319.1
	С	US-4,602,828	07-1986	Omata, Nobuaki	312/237
	D	US-4,893,522	01-1990	Arakawa, Masaru ·	188/290
	E	US-5,497,863	03-1996	Schmidt et al.	188/306
	F	US-5,277,282	01-1994	Umemura, Haruyuki	188/290
	G	US-6,840,353	01-2005	Arisaka, Oomi	188/83
	Н	US-4,694,530	09-1987	Foggini, Paolo	16/82
	ı	US-5,211,269	05-1993	Ohshima, Kazuyoshi	188/290
	J	US-4,828,344	05-1989	Omata, Nobuaki	312/319.1
	К	US-4,635,763	01-1987	Omata, Nobuaki	312/319.1
	L	US-5,052,728	10-1991	Fukumoto, Masumi	292/106
	М	US-4,660,881	04-1987	Komeya et al.	188/290

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 6-81533A	03-1994	Japan	Mitsutano et al.	
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.